

# Bipolar Junction Transistors

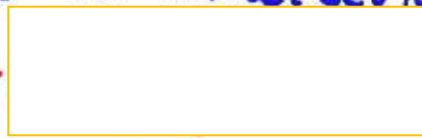
Recall key features of p-n junctions:

key  
Lectures

- Injection of minority carriers (forward bias)
- Variation of depletion widths (reverse bias)

Now consider 3-terminal device: Transistor

→ use for



and

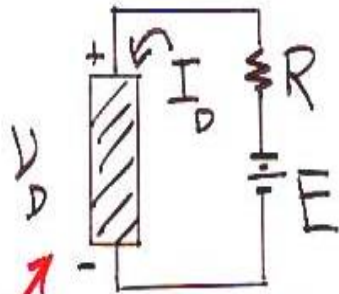


$e^-$  and  $h^+$  action both important:

Bipolar junction transistor

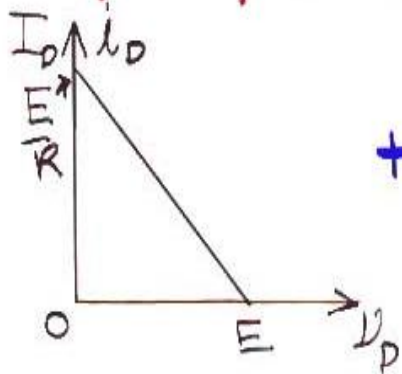
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Start with amplification (get a feeling for it)  
 2-Terminal device circuit looks like:

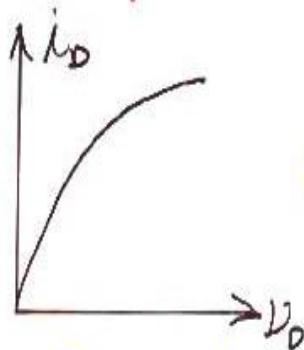


loop equation:  $E = I_D R + V_D$

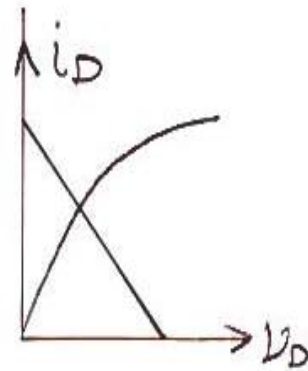
↑ my stery device  $I_D = f(V_D)$



+

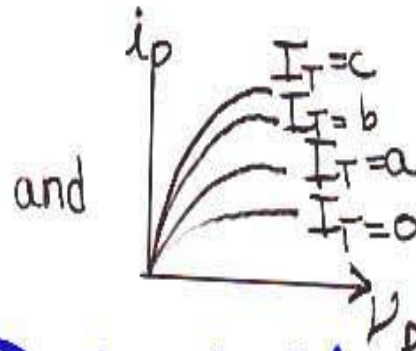
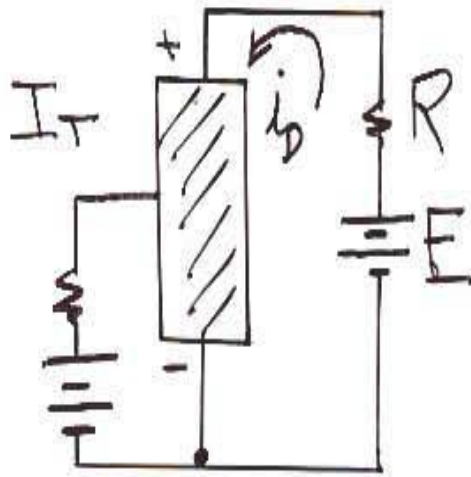


=



2 equations, 2 unknowns ( $I_D, V_D$ )

Now change to 3-terminal device  
→ Change  $i_o = f(V_o)$  in controlled way



family of  $f(V_o)$  curves

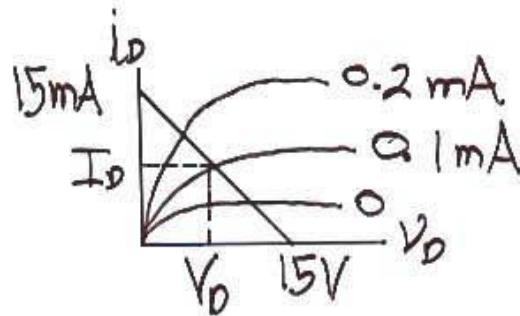
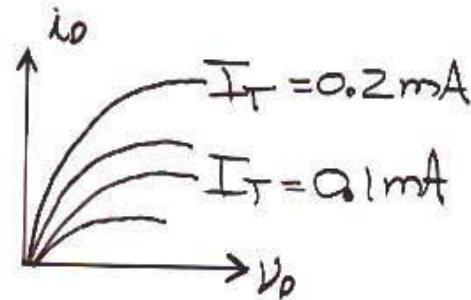
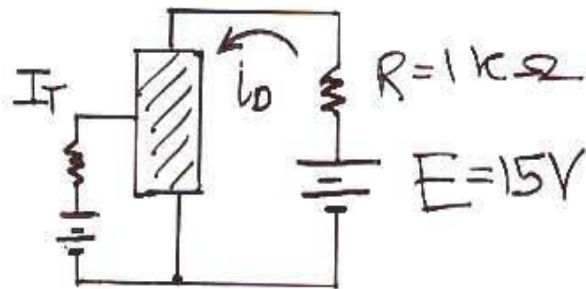
Terminology:

$I_o$  = Total Current

$I_o$  = d-c current

$i_o$  = a-c current

Put in values



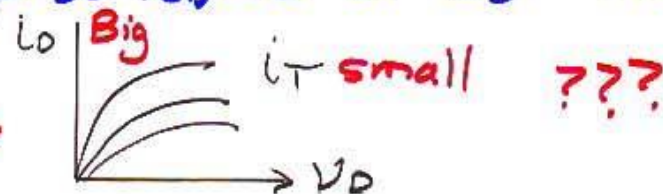
Now  $I_o$  and  $V_o$  depend on  $I_T$

Amplification: Change  $I_T$  by small amount (e.g., 0.05 mA)  
Get big change in  $I_o$  (e.g., 2 mA)

$$2.00 / 0.05 = 40 \times \text{factor}$$

Switching: change  $I_T$  so  $i_o = 0$  or  $i_o = E/R$

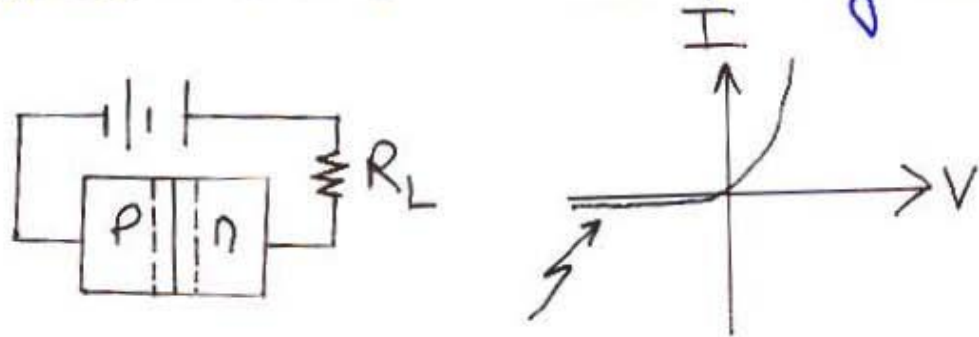
okay, but how come





## BJT Operation

To see how 3rd terminal changes  $I_0(V_0)$ ,  
consider reverse-biased p-n junction:



→  $I_0$  depends on rate of electron-hole pair creation  
within a diffusion length of the junction,  
(not on how fast field sweeps carriers through).

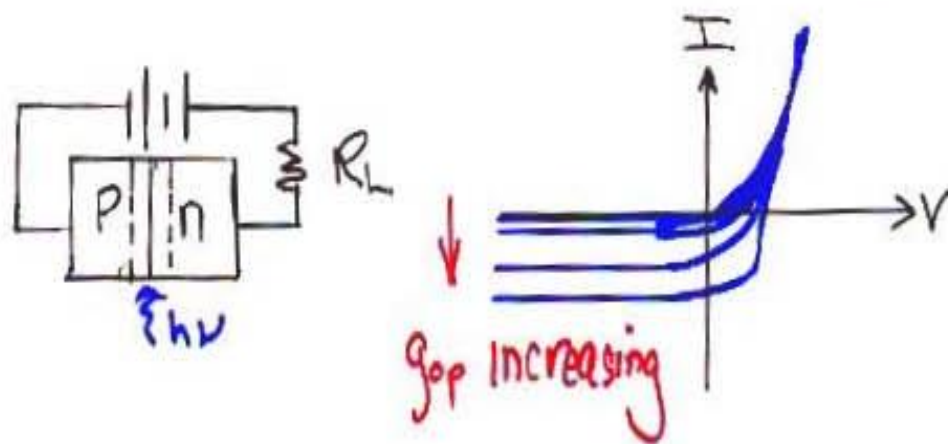
So what happens if we inject more <sup>Big Deal!</sup> electron-hole pairs?

We've already studied this!

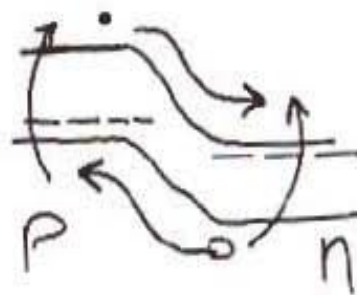
→ Use

Consider first.

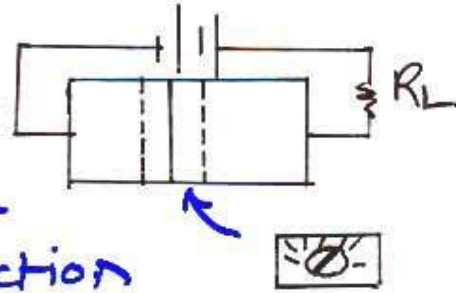
Consider first, optical injection:-



$h^+$  sweep from  $n \rightarrow p$   
 $e^-$  sweep from  $p \rightarrow n$   
 and reverse current increases.



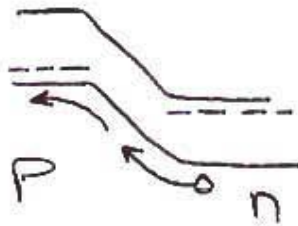
But same thing if different kind of hole injector:



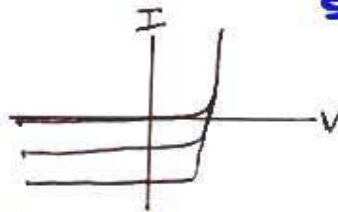
Behaves similar to optical injection

How?

Inject holes into n-side



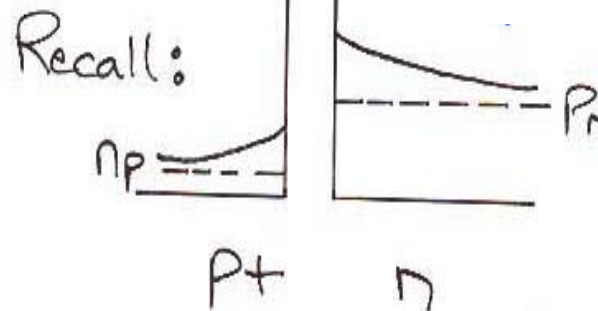
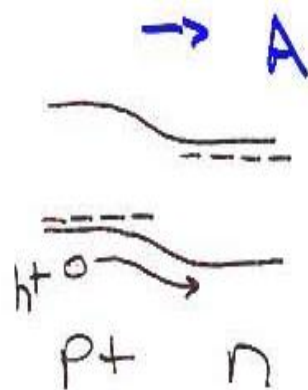
ht sweep  $n \rightarrow p$   
so more  $I_0$



$I \sim$  independent of bias  $V$ .

Also, current  $\sim$  independent of  $R_L$ .

What's a good hole injector?



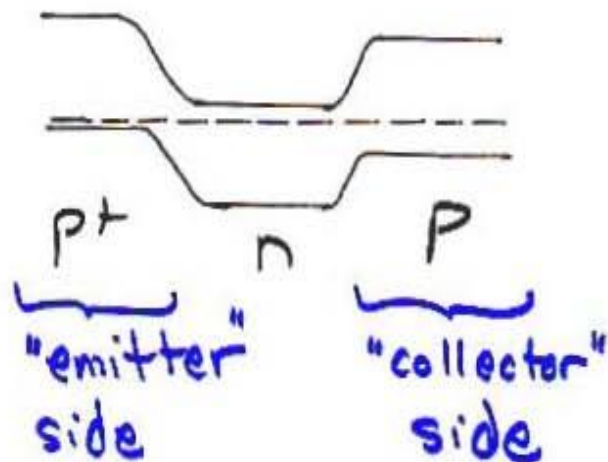
$p^+$  side is a supplier of holes =  
(majority carrier)



So now add the  $p^+n$  junction  
(the one we want to forward-bias)

to the  $n$ -side of the  $p$ - $n$  junction  
(the one we want to reverse-bias)

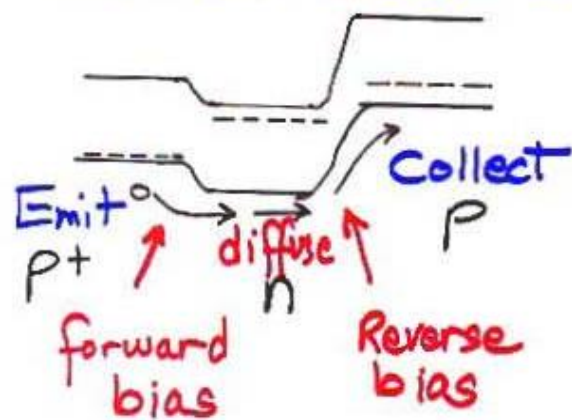
Looks like this:



$p^+$	$n$	$p$
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Equilibrium  
(no bias)

Forward-bias "emitter" to emit holes.  
Reverse-bias "collector" to collect holes.



"on"

Holes flow from emitter to collector.

Can turn off this transistor by reverse-biasing emitter.



"off"

No holes injected

PNP Transistor!

## Terminology

$P^+$  region = "emitter" (source of majority carriers - holes)

n region = "base"

p region = "collector" (collects majority carriers - holes)

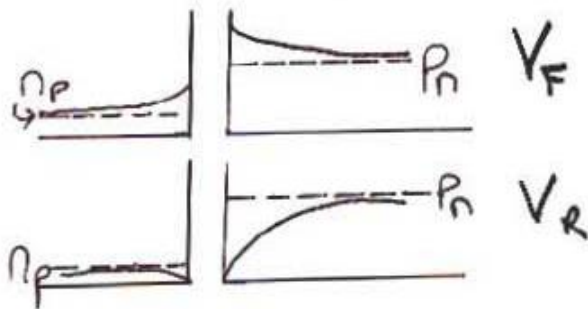
For good pnp transistors,

- inject almost all holes at emitter  
and
- collect almost all holes at collector

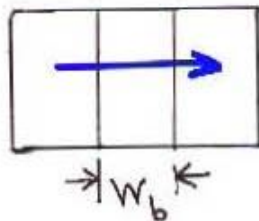
For good pnp transistors,

- a) inject almost all holes at emitter  
and
- b) collect almost all holes at collector

For (a), dope base lightly so holes dominate:



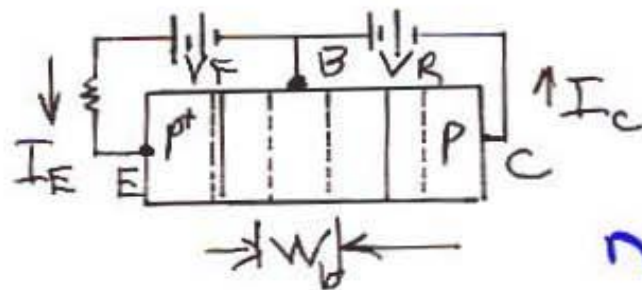
For (b), Make  $L_p \gg w_b$



Minimize

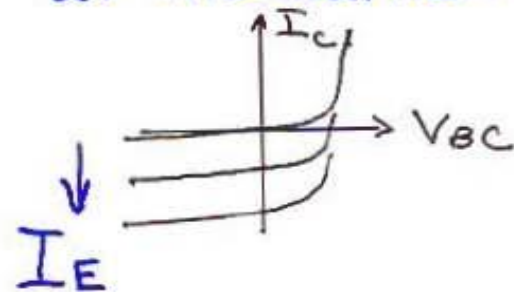


Now let's look at the magnitudes and directions of the currents.

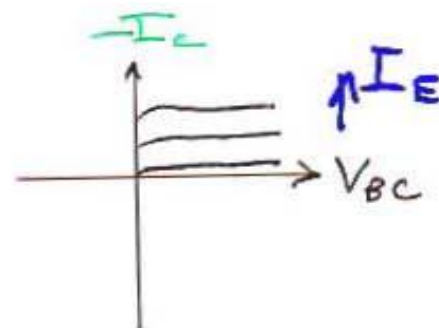


Neutral base region  
 "on" state biasing of "common-base" configuration

Can bias forward EB and reverse-bias BC at the same time!



Flip:



$I_E$  acts to increase reverse current of BC diode.



## Physical Sources of Current

Assume forward  $E \rightarrow B$  (above)

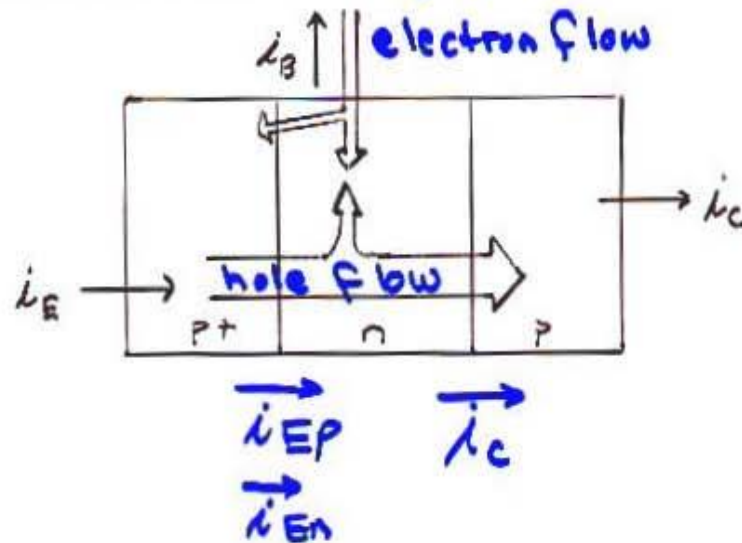
" reverse  $B \rightarrow C$  (above)

" pnp transistor (above)

$i_E$  Injected  $h^+$  current from  $E \rightarrow B = i_{EP}$   
"  $e^-$  " "  $B \rightarrow E = i_{EN}$   
(back injection)

$$\text{SO } i_E = i_{EP} + i_{EN}$$

$i_E$  (and  $i_C$ ) components:

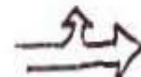


Important!

$i_C$ : collected  $h^+$  current from  $B \rightarrow C$

(Neglect saturation current ( $h^+$  and  $e^-$  both) since thermal generation in reverse bias is negligible)

$i_C =$  emitted  $h^+$  current from  $E \rightarrow B$   
 minus  $h^+$  lost to recombination



Hopefully,  is small, so treat  
as %.

$$i_c = B i_{EP}$$

$B$  = base transport factor  $\leq 1$   
= % that make it across.

$i_B =$   $e^-$  supply for recombination with  
 injected holes in n-type base  
 +  
 $e^-$  supply for  $i_{En}$

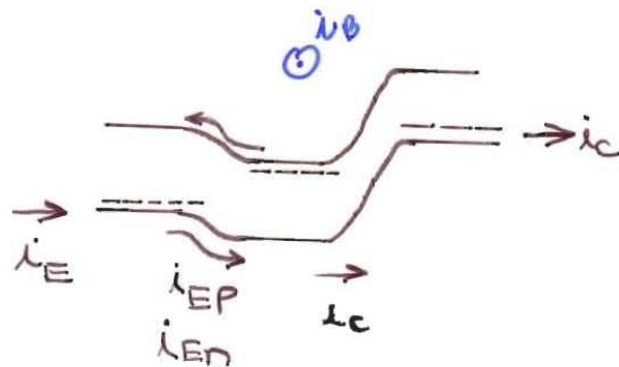
$$i_B = \underbrace{(1-\beta)}_{\text{fraction of injected hole current that recombines}} i_{EP} + i_{En}$$

fraction of injected hole current that recombines.

For pnp BJT,  $i_E$  flows into emitter

$i_C$  flows out of collector

$i_B$



For n p n BJT, roles of electrons and holes are reversed.

### Amplification

BJT useful since currents  $i_E$  and  $i_C$  controllable by small base current  $i_B$ .

Relate all three by important factors:

$$i_C = \beta i_{EP} \quad (\text{again})$$

$\beta$  = base transport factor  $\leq 1$

fraction that make it across base

Define: Emitter Injection Efficiency

$\gamma =$



fraction of  $i_E$  composed of holes



$$\gamma = \frac{i_{EP}}{i_{EP} + i_{EN}}$$

fraction of  $i_E$  composed of holes

Ideally,  $\gamma \approx 1$  and  $\beta \approx 1$

Relate  $i_C$  to  $i_E$ :

$$\frac{i_C}{i_E} = \boxed{\phantom{000}} \boxed{\phantom{000}} \equiv \alpha \quad \leftarrow \text{Current Transfer Ratio}$$

$\alpha$  close to unity - no real amplification.

(Emitter-to-Collector)

Base Current relations:

$$\frac{i_c}{i_b} = \frac{\beta i_{EP}}{(1-\beta)i_{EP} + i_{EN}} = \frac{\beta(i_{EP}/(i_{EP} + i_{EN}))}{[(1-\beta)i_{EP} + i_{EN}]/(i_{EP} + i_{EN})}$$
$$= \frac{\beta(i_{EP}/(i_{EP} + i_{EN}))}{1 - \beta(i_{EP}/(i_{EP} + i_{EN}))}$$

$$= \boxed{\phantom{000000}}$$

$$= \boxed{\phantom{000000}}$$

$$\equiv \beta$$

Base-to-Collector Amplification Ratio  
or Factor